

Maximum Ratings (Ta = 25°C)

Characteristic		Symbol	Rating	Unit
Collector-emitter voltage		V_{CES}	600	V
Gate-emitter voltage		V_{GES}	± 20	V
Collector current	DC	I_C	75	A
	1ms	I_{CP}	150	
Forward current	DC	I_F	75	A
	1ms	I_{FM}	150	
Collector power dissipation (Tc = 25°C)		P_C	390	W
Junction temperature		T_j	150	°C
Storage temperature range		T_{stg}	-40 ~ 125	°C
Isolation voltage		V_{isol}	2500 (AC 1 min.)	V
Screw torque (Terminal / mounting)		—	2 / 3	N·m

Electrical Characteristics (Ta = 25°C)

Characteristic		Symbol	Test Condition	Min	Typ.	Max	Unit
Gate leakage current		I_{GES}	$V_{GE} = \pm 20V, V_{CE} = 0$	—	—	± 500	nA
Collector cut-off current		I_{CES}	$V_{CE} = 600V, V_{GE} = 0$	—	—	1.0	mA
Gate-emitter cut-off voltage		$V_{GE (off)}$	$I_C = 7.5mA, V_{CE} = 5V$	5.0	7.0	8.0	V
Collector-emitter saturation voltage		$V_{CE (sat)}$	$I_C = 75A, V_{GE} = 15V$	—	2.10	2.70	V
Input capacitance		C_{ies}	$V_{CE} = 10V, V_{GE} = 0, f = 1MHz$	—	7100	—	pF
Switching time	Turn-on delay time	$t_{d (on)}$	Inductive load $V_{CC} = 300V$ $I_C = 75A$ $V_{GE} = \pm 15V$ $R_G = 18\Omega$ (Note 1)	—	0.08	0.16	μs
	Rise time	t_r		—	0.12	0.24	
	Turn-on time	t_{on}		—	0.40	0.80	
	Turn-off delay time	$t_{d (off)}$		—	0.20	0.40	
	Fall time	t_f		—	0.15	0.30	
	Turn-off time	t_{off}		—	0.50	1.00	
Forward voltage		V_F	$I_F = 75A, V_{GE} = 0$	—	2.10	2.80	V
Reverse recovery time		t_{rr}	$I_F = 75A, V_{GE} = -10V$ $di / dt = 100A / \mu s$	—	0.08	0.15	μs
Thermal resistance		$R_{th (j-c)}$	Transistor	—	—	0.32	°C / W
			Diode	—	—	0.69	

Note 1: Switching time test circuit & timing chart







